

MOSFETs Silicon N-channel MOS (U-MOS<sup>III</sup>-H)

# TPN22006NH

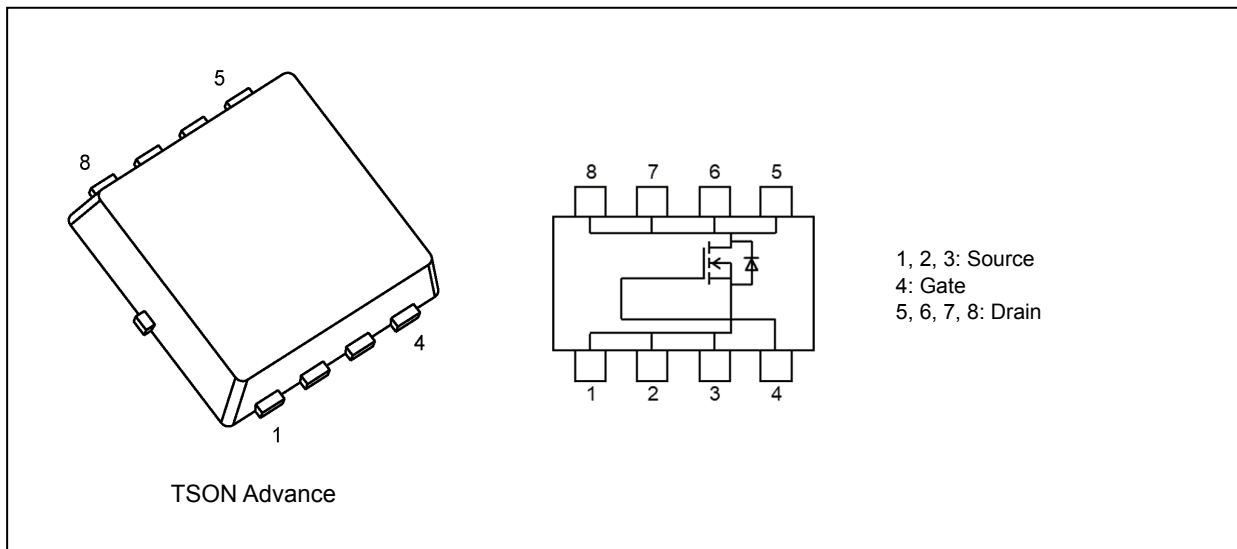
## 1. Applications

- Switching Voltage Regulators
- Motor Drivers
- DC-DC Converters

## 2. Features

- (1) Small footprint due to a small and thin package
- (2) High-speed switching
- (3) Small gate charge:  $Q_{SW} = 4.5 \text{ nC}$  (typ.)
- (4) Low drain-source on-resistance:  $R_{DS(ON)} = 18 \text{ m}\Omega$  (typ.)
- (5) Low leakage current:  $I_{DSS} = 10 \text{ }\mu\text{A}$  (max) ( $V_{DS} = 60 \text{ V}$ )
- (6) Enhancement mode:  $V_{th} = 2.0 \text{ to } 4.0 \text{ V}$  ( $V_{DS} = 10 \text{ V}$ ,  $I_D = 0.1 \text{ mA}$ )

## 3. Packaging and Internal Circuit



Start of commercial production  
2012-08

### 4. Absolute Maximum Ratings (Note) ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                                       | Symbol    | Rating     | Unit             |
|---|-----------|------------|------------------|
| Drain-source voltage                                  | $V_{DSS}$ | 60         | V                |
| Gate-source voltage                                   | $V_{GSS}$ | $\pm 20$   |                  |
| Drain current (DC) (Silicon limit) (Note 1), (Note 2) | $I_D$     | 21         | A                |
| Drain current (DC) (Note 1)                           | $I_D$     | 9          |                  |
| Drain current (pulsed) ( $t = 1$ ms) (Note 1)         | $I_{DP}$  | 42         |                  |
| Power dissipation ( $T_c = 25^\circ\text{C}$ )        | $P_D$     | 18         | W                |
| Power dissipation ( $t = 10$ s) (Note 3)              | $P_D$     | 1.9        | W                |
| Power dissipation ( $t = 10$ s) (Note 4)              | $P_D$     | 0.7        | W                |
| Single-pulse avalanche energy (Note 5)                | $E_{AS}$  | 21         | mJ               |
| Avalanche current                                     | $I_{AR}$  | 9          | A                |
| Channel temperature                                   | $T_{ch}$  | 150        | $^\circ\text{C}$ |
| Storage temperature                                   | $T_{stg}$ | -55 to 150 |                  |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

### 5. Thermal Characteristics

| Characteristics   | Symbol         | Max  | Unit                      |
|---|----------------|------|---------------------------|
| Channel-to-case thermal resistance ( $T_c = 25^\circ\text{C}$ ) | $R_{th(ch-c)}$ | 6.94 | $^\circ\text{C}/\text{W}$ |
| Channel-to-ambient thermal resistance ( $t = 10$ s) (Note 3)    | $R_{th(ch-a)}$ | 65.7 | $^\circ\text{C}/\text{W}$ |
| Channel-to-ambient thermal resistance ( $t = 10$ s) (Note 4)    | $R_{th(ch-a)}$ | 178  | $^\circ\text{C}/\text{W}$ |

Note 1: Ensure that the channel temperature does not exceed  $150^\circ\text{C}$ .

Note 2: Limited by silicon capability.

Note 3: Device mounted on a glass-epoxy board (a), Figure 5.1

Note 4: Device mounted on a glass-epoxy board (b), Figure 5.2

Note 5:  $V_{DD} = 48$  V,  $T_{ch} = 25^\circ\text{C}$  (initial),  $L = 0.2$  mH,  $I_{AR} = 9$  A



Fig. 5.1 Device Mounted on a Glass-Epoxy Board (a)

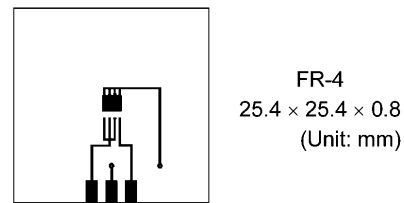


Fig. 5.2 Device Mounted on a Glass-Epoxy Board (b)

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

### 6. Electrical Characteristics

#### 6.1. Static Characteristics ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                         | Symbol        | Test Condition                                  | Min | Typ. | Max       | Unit             |
|---|---------------|---|-----|------|-----------|------------------|
| Gate leakage current                    | $I_{GSS}$     | $V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$ | —   | —    | $\pm 0.1$ | $\mu\text{A}$    |
| Drain cut-off current                   | $I_{DSS}$     | $V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}$     | —   | —    | 10        |                  |
| Drain-source breakdown voltage          | $V_{(BR)DSS}$ | $I_D = 10\text{ mA}, V_{GS} = 0\text{ V}$       | 60  | —    | —         | V                |
| Drain-source breakdown voltage (Note 6) | $V_{(BR)DSX}$ | $I_D = 10\text{ mA}, V_{GS} = -20\text{ V}$     | 45  | —    | —         |                  |
| Gate threshold voltage                  | $V_{th}$      | $V_{DS} = 10\text{ V}, I_D = 0.1\text{ mA}$     | 2.0 | —    | 4.0       |                  |
| Drain-source on-resistance              | $R_{DS(ON)}$  | $V_{GS} = 6.5\text{ V}, I_D = 4.5\text{ A}$     | —   | 28   | 64        | $\text{m}\Omega$ |
|   |               | $V_{GS} = 10\text{ V}, I_D = 4.5\text{ A}$      | —   | 18   | 22        |                  |

Note 6: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

#### 6.2. Dynamic Characteristics ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                | Symbol    | Test Condition  | Min | Typ. | Max | Unit        |
|--------------------------------|-----------|---|-----|------|-----|-------------|
| Input capacitance              | $C_{iss}$ | $V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ | —   | 710  | —   | $\text{pF}$ |
| Reverse transfer capacitance   | $C_{rss}$ |   | —   | 14   | —   |             |
| Output capacitance             | $C_{oss}$ |   | —   | 235  | —   |             |
| Gate resistance                | $r_g$     | —   | —   | 1.0  | 1.5 | $\Omega$    |
| Switching time (rise time)     | $t_r$     | See Figure 6.2.1.   | —   | 4.6  | —   | ns          |
| Switching time (turn-on time)  | $t_{on}$  |   | —   | 13   | —   |             |
| Switching time (fall time)     | $t_f$     |   | —   | 3.3  | —   |             |
| Switching time (turn-off time) | $t_{off}$ |   | —   | 13   | —   |             |

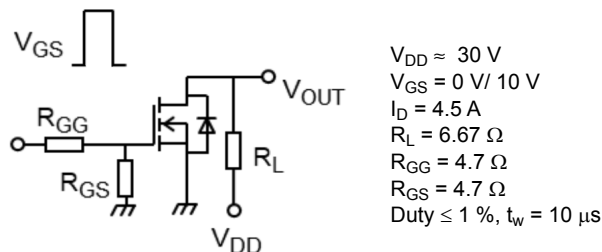


Fig. 6.2.1 Switching Time (Fig.)

#### 6.3. Gate Charge Characteristics ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                                 | Symbol    | Test Condition   | Min | Typ. | Max | Unit |
|---|-----------|--|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | $Q_g$     | $V_{DD} \approx 30\text{ V}, V_{GS} = 10\text{ V}, I_D = 9\text{ A}$ | —   | 12   | —   | nC   |
| Gate-source charge 1                            | $Q_{gs1}$ |  | —   | 3.9  | —   |      |
| Gate-drain charge                               | $Q_{gd}$  |  | —   | 3.0  | —   |      |
| Gate switch charge                              | $Q_{sw}$  |  | —   | 4.5  | —   |      |

#### 6.4. Source-Drain Characteristics ( $T_a = 25^\circ\text{C}$ unless otherwise specified)

| Characteristics                         | Symbol    | Test Condition                             | Min | Typ. | Max  | Unit |
|---|-----------|--|-----|------|------|------|
| Reverse drain current (pulsed) (Note 7) | $I_{DRP}$ | —  | —   | —    | 42   | A    |
| Diode forward voltage                   | $V_{DSF}$ | $I_{DR} = 9\text{ A}, V_{GS} = 0\text{ V}$ | —   | —    | -1.2 | V    |

Note 7: Ensure that the channel temperature does not exceed  $150^\circ\text{C}$ .

## 7. Marking

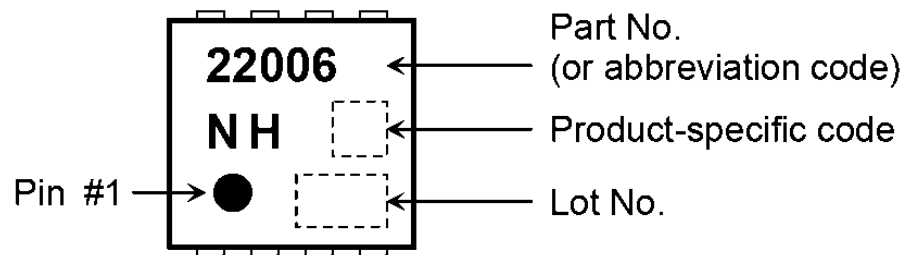


Fig. 7.1 Marking

## 8. Characteristics Curves (Note)

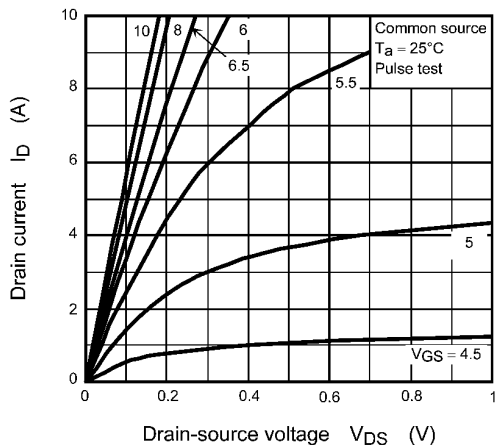


Fig. 8.1  $I_D - V_{DS}$

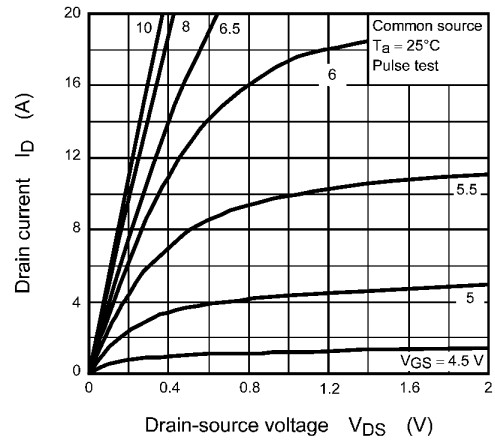


Fig. 8.2  $I_D - V_{DS}$

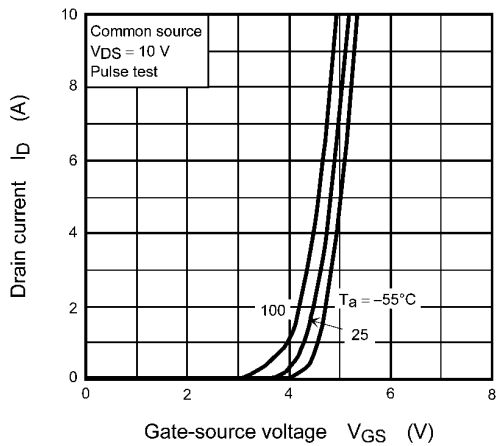


Fig. 8.3  $I_D - V_{GS}$

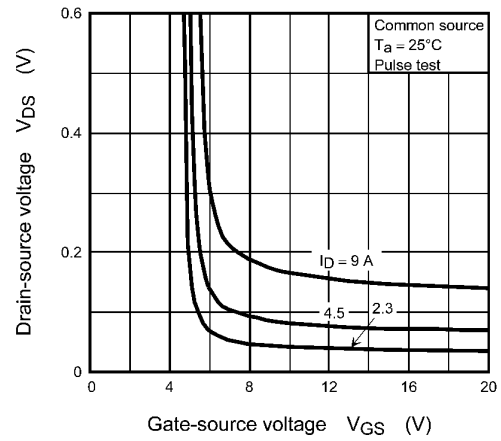


Fig. 8.4  $V_{DS} - V_{GS}$

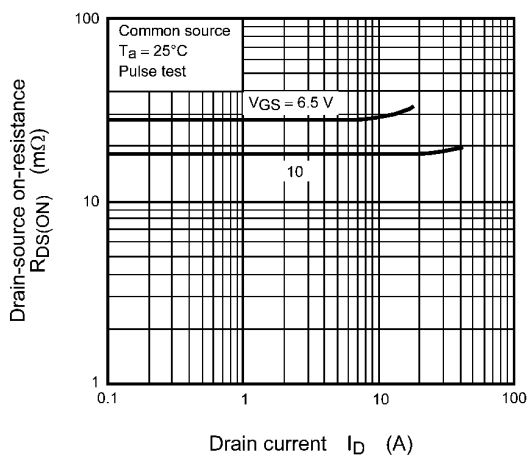


Fig. 8.5  $R_{DS(ON)} - I_D$

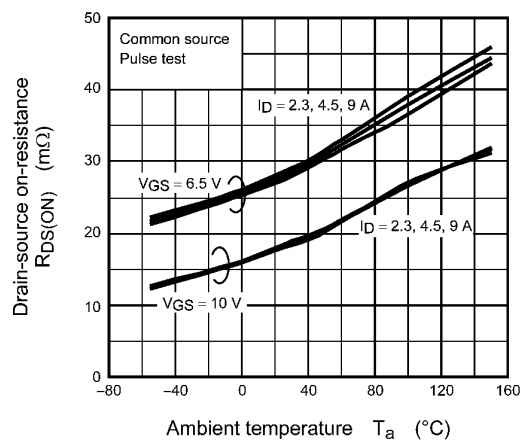
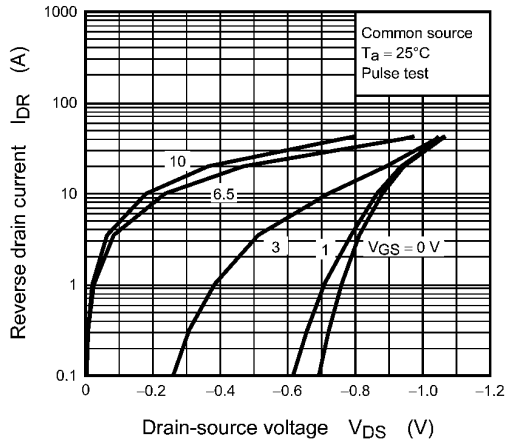
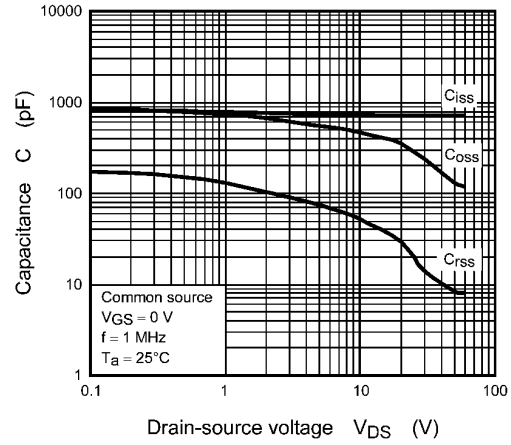


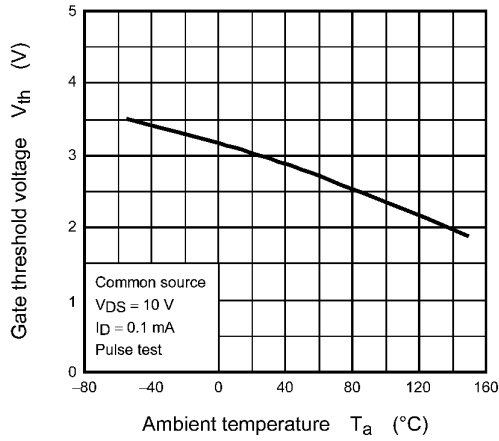
Fig. 8.6  $R_{DS(ON)} - T_a$



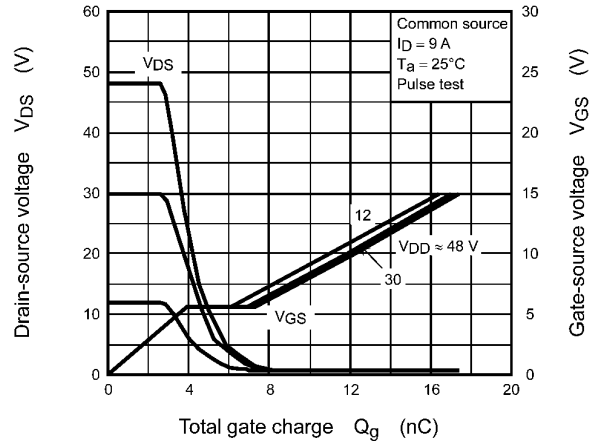
**Fig. 8.7  $I_{DR} - V_{DS}$**



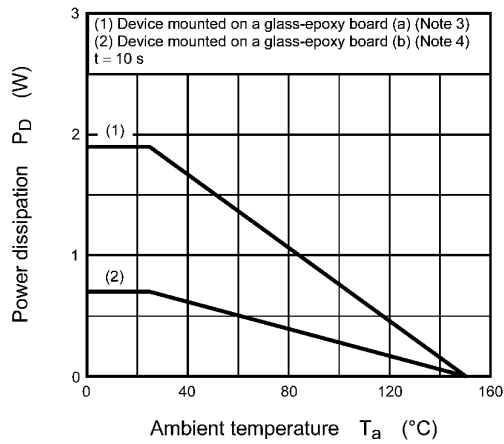
**Fig. 8.8 Capacitance -  $V_{DS}$**



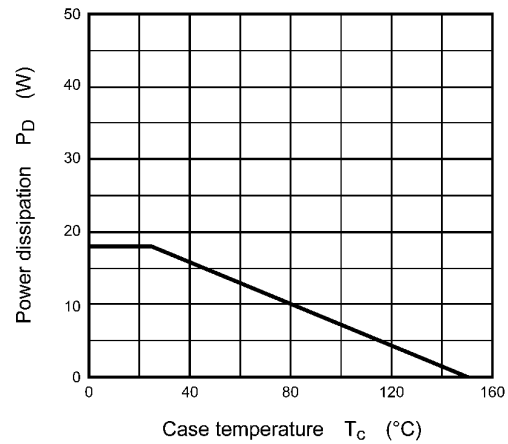
**Fig. 8.9  $V_{th} - T_a$**



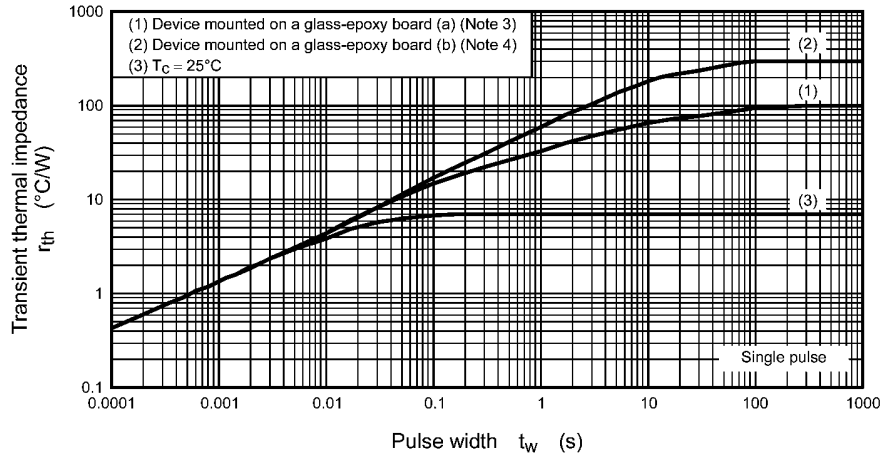
**Fig. 8.10 Dynamic Input/Output Characteristics**



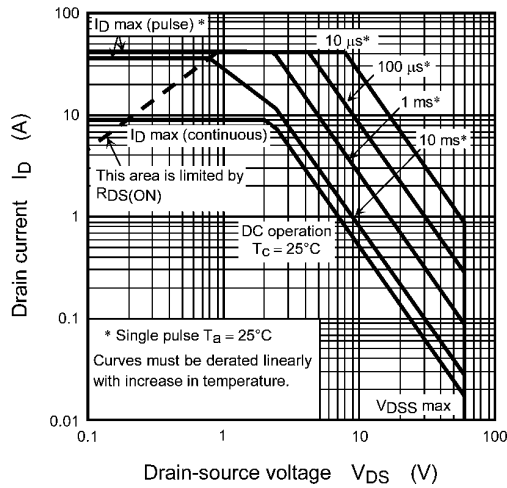
**Fig. 8.11  $P_D - T_a$   
(Guaranteed Maximum)**



**Fig. 8.12  $P_D - T_c$   
(Guaranteed Maximum)**



**Fig. 8.13  $r_{th} - t_w$**   
(Guaranteed Maximum)



**Fig. 8.14 Safe Operating Area**  
(Guaranteed Maximum)

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



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